

<b>Notice of References Cited</b>	Application/Control No. 10/533,432		Applicant(s)/Patent Under Reexamination HIDAKA ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2002-226871	08-2002	Japan	Hitoshi et al	
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#### NON-PATENT DOCUMENTS

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